

# IRLML2502

HEXFET® Power MOSFET

- Ultra Low On-Resistance
- N-Channel MOSFET
- SOT-23 Footprint
- Low Profile (<1.1mm)
- Available in Tape and Reel
- Fast Switching

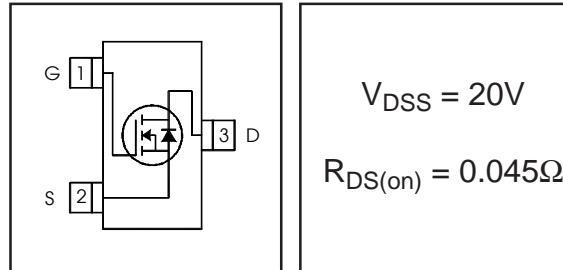
## Description

These N-Channel MOSFETs from International Rectifier utilize advanced processing techniques to achieve extremely low on-resistance per silicon area. This benefit, combined with the fast switching speed and ruggedized device design that HEXFET® power MOSFETs are well known for, provides the designer with an extremely efficient and reliable device for use in battery and load management.

A thermally enhanced large pad leadframe has been incorporated into the standard SOT-23 package to produce a HEXFET Power MOSFET with the industry's smallest footprint. This package, dubbed the Micro3™, is ideal for applications where printed circuit board space is at a premium. The low profile (<1.1mm) of the Micro3 allows it to fit easily into extremely thin application environments such as portable electronics and PCMCIA cards. The thermal resistance and power dissipation are the best available.

## Absolute Maximum Ratings

	Parameter	Max.	Units
$V_{DS}$	Drain- Source Voltage	20	V
$I_D @ T_A = 25^\circ C$	Continuous Drain Current, $V_{GS} @ 4.5V$	4.2	A
$I_D @ T_A = 70^\circ C$	Continuous Drain Current, $V_{GS} @ 4.5V$	3.4	
$I_{DM}$	Pulsed Drain Current ①	33	
$P_D @ T_A = 25^\circ C$	Power Dissipation	1.25	W
$P_D @ T_A = 70^\circ C$	Power Dissipation	0.8	
	Linear Derating Factor	0.01	W/ $^\circ C$
$V_{GS}$	Gate-to-Source Voltage	$\pm 12$	V
$T_J, T_{STG}$	Junction and Storage Temperature Range	-55 to + 150	$^\circ C$



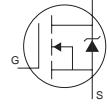
## Thermal Resistance

	Parameter	Typ.	Max.	Units
$R_{0JA}$	Maximum Junction-to-Ambient ②	75	100	$^\circ C/W$

**Electrical Characteristics @  $T_J = 25^\circ\text{C}$  (unless otherwise specified)**

	Parameter	Min.	Typ.	Max.	Units	Conditions
$V_{(\text{BR})\text{DSS}}$	Drain-to-Source Breakdown Voltage	20	—	—	V	$V_{\text{GS}} = 0\text{V}$ , $I_D = 250\mu\text{A}$
$\Delta V_{(\text{BR})\text{DSS}/\Delta T_J}$	Breakdown Voltage Temp. Coefficient	—	0.01	—	$\text{V}^\circ\text{C}$	Reference to $25^\circ\text{C}$ , $I_D = 1\text{mA}$
$R_{\text{DS}(\text{on})}$	Static Drain-to-Source On-Resistance	—	0.035	0.045	$\Omega$	$V_{\text{GS}} = 4.5\text{V}$ , $I_D = 4.2\text{A}$ ②
		—	0.050	0.080		$V_{\text{GS}} = 2.5\text{V}$ , $I_D = 3.6\text{A}$ ②
$V_{\text{GS}(\text{th})}$	Gate Threshold Voltage	0.60	—	1.2	V	$V_{\text{DS}} = V_{\text{GS}}$ , $I_D = 250\mu\text{A}$
$g_{\text{fs}}$	Forward Transconductance	5.8	—	—	S	$V_{\text{DS}} = 10\text{V}$ , $I_D = 4.0\text{A}$
$I_{\text{DSS}}$	Drain-to-Source Leakage Current	—	—	1.0	$\mu\text{A}$	$V_{\text{DS}} = 16\text{V}$ , $V_{\text{GS}} = 0\text{V}$
		—	—	25		$V_{\text{DS}} = 16\text{V}$ , $V_{\text{GS}} = 0\text{V}$ , $T_J = 70^\circ\text{C}$
$I_{\text{GSS}}$	Gate-to-Source Forward Leakage	—	—	-100	nA	$V_{\text{GS}} = -12\text{V}$
	Gate-to-Source Reverse Leakage	—	—	100		$V_{\text{GS}} = 12\text{V}$
$Q_g$	Total Gate Charge	—	8.0	12	nC	$I_D = 4.0\text{A}$
$Q_{\text{gs}}$	Gate-to-Source Charge	—	1.8	2.7		$V_{\text{DS}} = 10\text{V}$
$Q_{\text{gd}}$	Gate-to-Drain ("Miller") Charge	—	1.7	2.6		$V_{\text{GS}} = 5.0\text{V}$ ②
$t_{\text{d}(\text{on})}$	Turn-On Delay Time	—	7.5	—	ns	$V_{\text{DD}} = 10\text{V}$
$t_r$	Rise Time	—	10	—		$I_D = 1.0\text{A}$
$t_{\text{d}(\text{off})}$	Turn-Off Delay Time	—	54	—		$R_G = 6\Omega$
$t_f$	Fall Time	—	26	—		$R_D = 10\Omega$ ②
$C_{\text{iss}}$	Input Capacitance	—	740	—	pF	$V_{\text{GS}} = 0\text{V}$
$C_{\text{oss}}$	Output Capacitance	—	90	—		$V_{\text{DS}} = 15\text{V}$
$C_{\text{rss}}$	Reverse Transfer Capacitance	—	66	—		$f = 1.0\text{MHz}$

**Source-Drain Ratings and Characteristics**

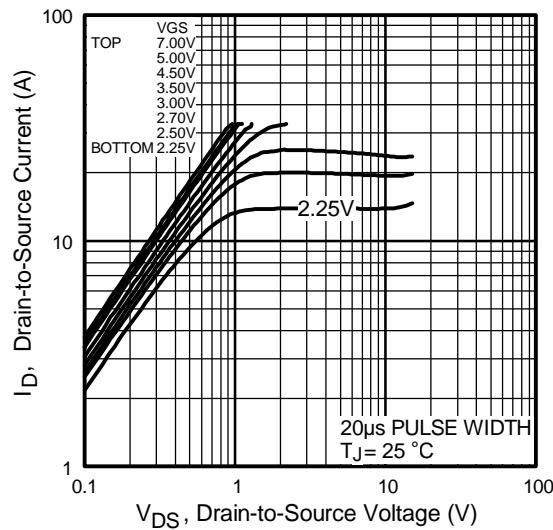
	Parameter	Min.	Typ.	Max.	Units	Conditions
$I_S$	Continuous Source Current (Body Diode)	—	—	1.3	A	MOSFET symbol showing the integral reverse p-n junction diode.
	Pulsed Source Current (Body Diode) ①	—	—	33		
$V_{\text{SD}}$	Diode Forward Voltage	—	—	1.2	V	$T_J = 25^\circ\text{C}$ , $I_S = 1.3\text{A}$ , $V_{\text{GS}} = 0\text{V}$ ②
$t_{\text{rr}}$	Reverse Recovery Time	—	16	24	ns	$T_J = 25^\circ\text{C}$ , $I_F = 1.3\text{A}$
$Q_{\text{rr}}$	Reverse Recovery Charge	—	8.6	13	nC	$dI/dt = 100\text{A}/\mu\text{s}$ ②

**Notes:**

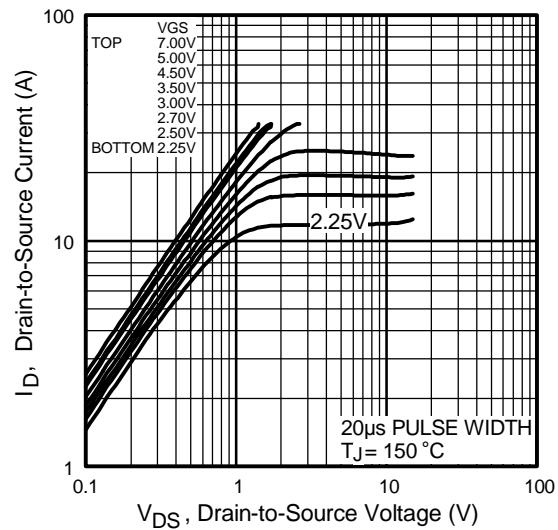
① Repetitive rating; pulse width limited by max. junction temperature. ( See fig. 11 )

② Pulse width  $\leq 300\mu\text{s}$ ; duty cycle  $\leq 2\%$ .

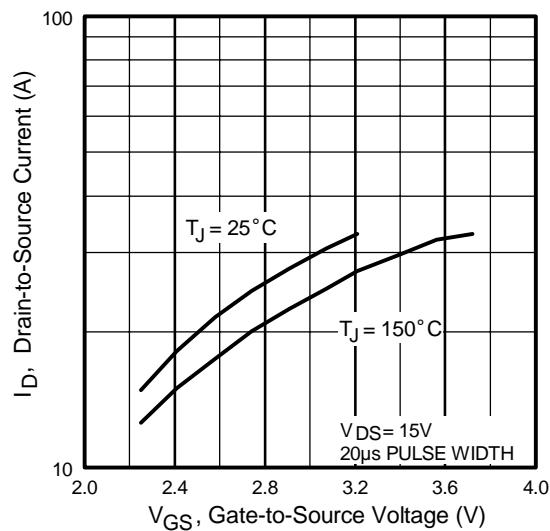
③ Surface mounted on FR-4 board,  $t \leq 5\text{sec}$ .



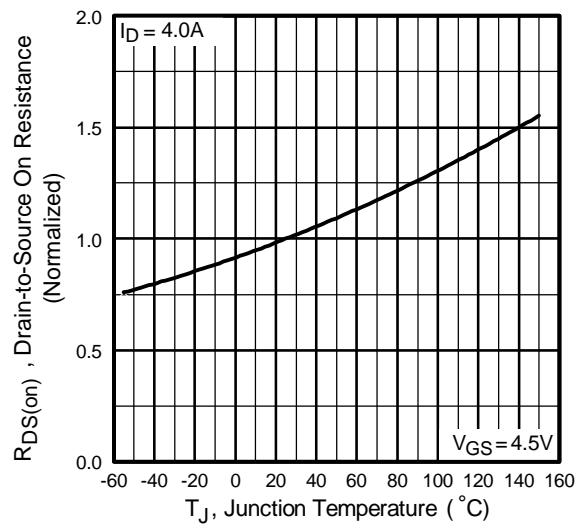
**Fig 1.** Typical Output Characteristics



**Fig 2.** Typical Output Characteristics



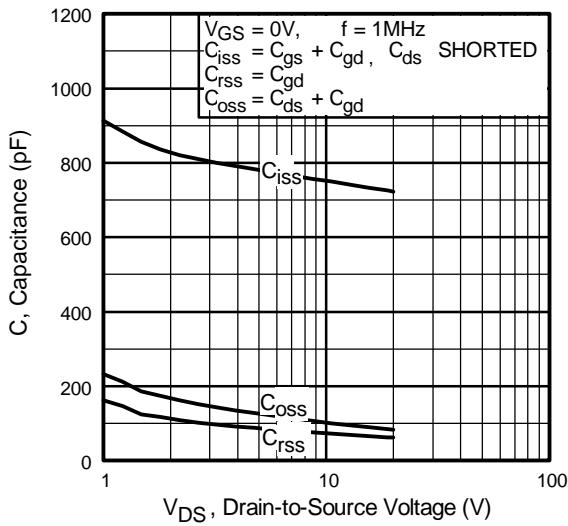
**Fig 3.** Typical Transfer Characteristics



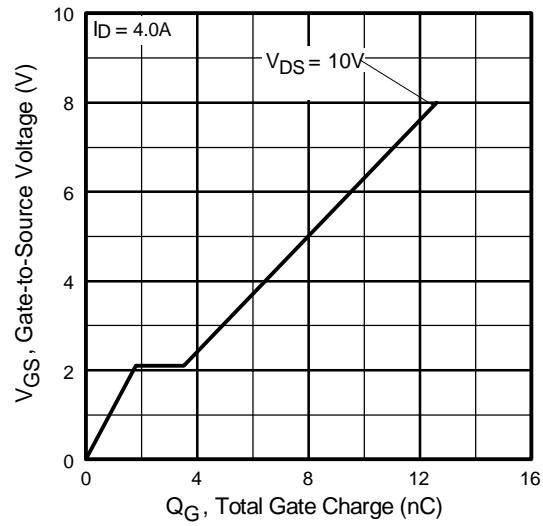
**Fig 4.** Normalized On-Resistance  
Vs. Temperature

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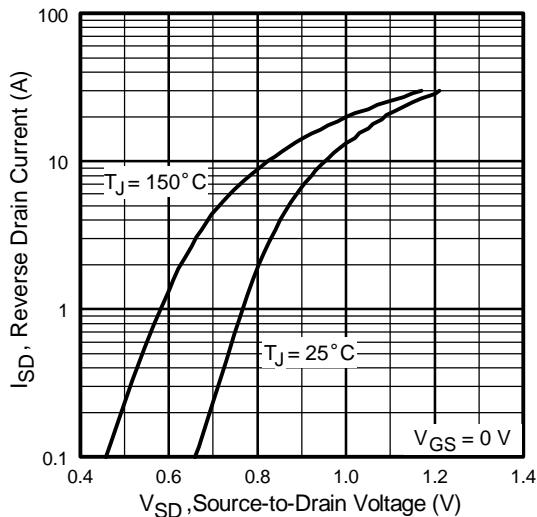
International  
Rectifier



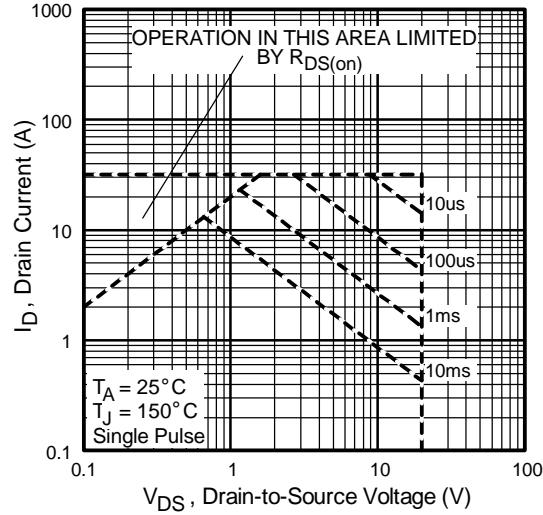
**Fig 5.** Typical Capacitance Vs.  
Drain-to-Source Voltage



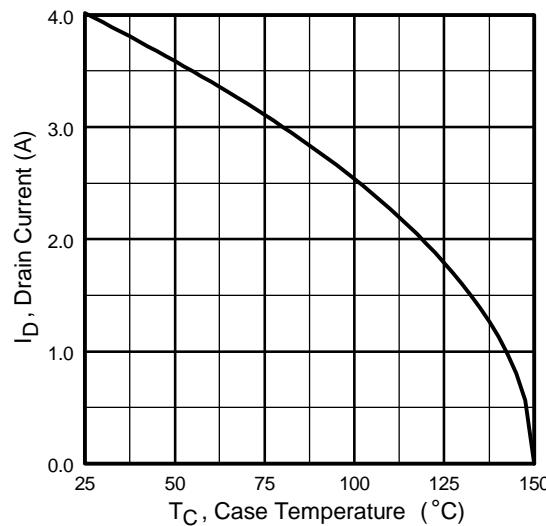
**Fig 6.** Typical Gate Charge Vs.  
Gate-to-Source Voltage



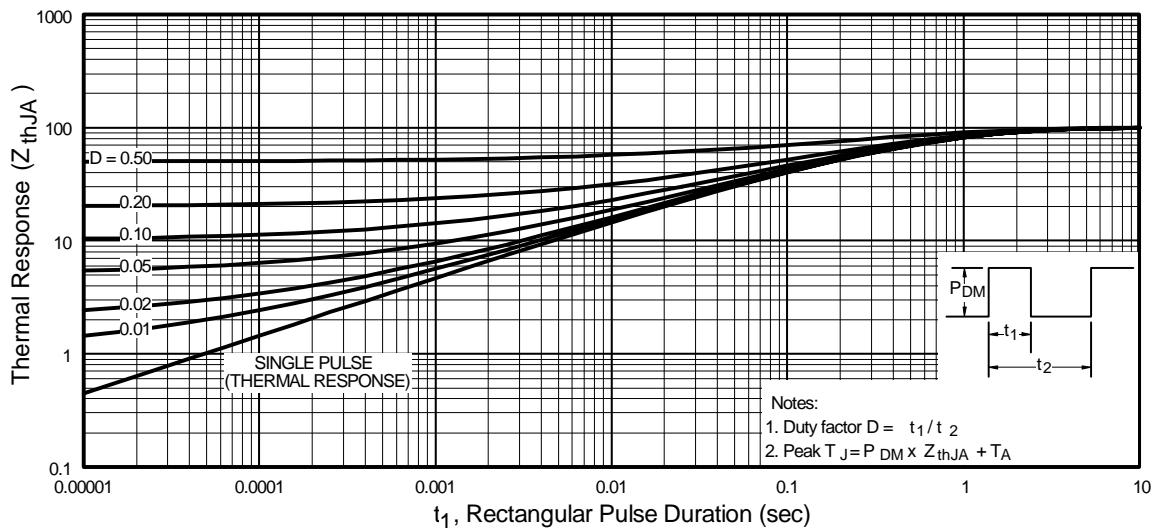
**Fig 7.** Typical Source-Drain Diode  
Forward Voltage



**Fig 8.** Maximum Safe Operating Area



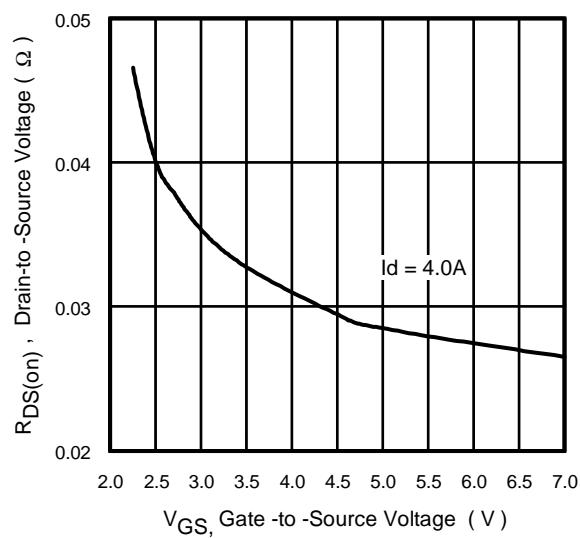
**Fig 9.** Maximum Drain Current Vs.  
 Case Temperature



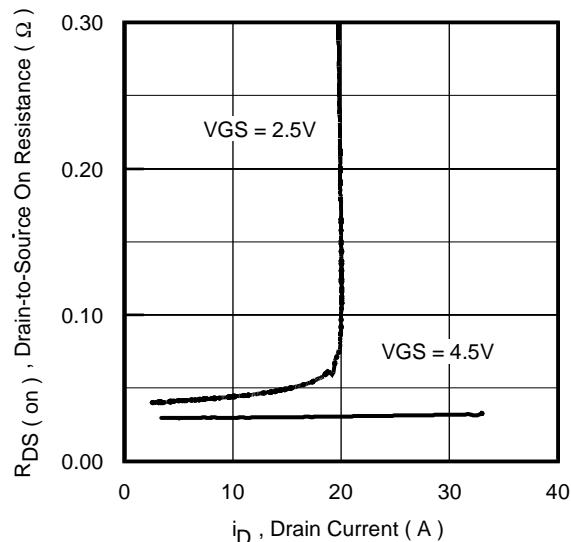
**Fig 10.** Maximum Effective Transient Thermal Impedance, Junction-to-Ambient

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International  
**IR** Rectifier



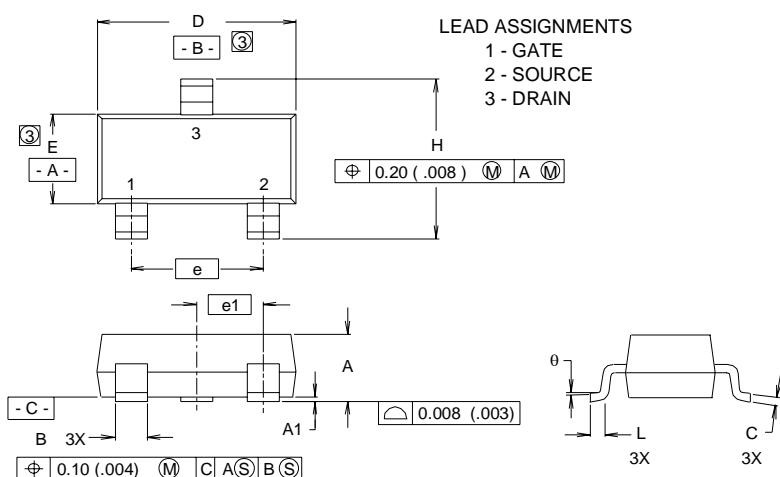
**Fig 11.** On-Resistance Vs. Gate Voltage



**Fig 12.** On-Resistance Vs. Drain Current

## Micro3™ Package Outline

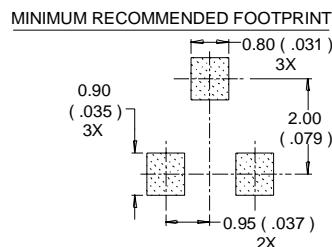
Dimensions are shown in millimeters (inches)



LEAD ASSIGNMENTS  
 1 - GATE  
 2 - SOURCE  
 3 - DRAIN

- NOTES:  
 1. DIMENSIONING & TOLERANCING PER ANSI Y14.5M-1982.  
 2. CONTROLLING DIMENSION : INCH.  
 ③ DIMENSIONS DO NOT INCLUDE MOLD FLASH.

DIM	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX
A	.032	.044	0.82	1.11
A1	.001	.004	0.02	0.10
B	.015	.021	0.38	0.54
C	.004	.006	0.10	0.15
D	.105	.120	2.67	3.05
e	.0750 BASIC		1.90 BASIC	
e1	.0375 BASIC		0.95 BASIC	
E	.047	.055	1.20	1.40
H	.083	.098	2.10	2.50
L	.005	.010	0.13	0.25
θ	0°	8°	0°	8°



# IRLML2502

## Part Marking Information

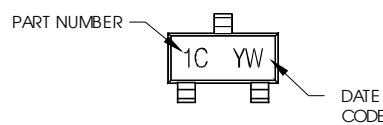
Micro3™

International  
**IR** Rectifier

Notes: This part marking information applies to devices produced before 02/26/2001

EXAMPLE: THIS IS AN IRLML6302

WW = (1-26) IF PRECEDED BY LAST DIGIT OF CALENDAR YEAR



PART NUMBER CODE REFERENCE:

1A = IRLML2402

1B = IRLML2803

1C = IRLML6302

1D = IRLML5103

1E = IRLML6402

1F = IRLML6401

1G = IRLML2502

1H = IRLML5203

DATE CODE EXAMPLES:

YWW = 9503 = 5C

YWW = 9532 = EF

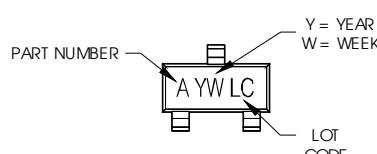
YEAR	Y	WORK WEEK	W
2001	1	01	A
2002	2	02	B
2003	3	03	C
1994	4	04	D
1995	5		
1996	6		
1997	7		
1998	8		
1999	9		
2000	0	24	X
		25	Y
		26	Z

WW = (27-52) IF PRECEDED BY A LETTER

YEAR	Y	WORK WEEK	W
2001	A	27	A
2002	B	28	B
2003	C	29	C
1994	D	30	D
1995	E		
1996	F		
1997	G		
1998	H		
1999	J		
2000	K	50	X
		51	Y
		52	Z

Notes: This part marking information applies to devices produced after 02/26/2001

W = (1-26) IF PRECEDED BY LAST DIGIT OF CALENDAR YEAR



PART NUMBER CODE REFERENCE:

A = IRLML2402

B = IRLML2803

C = IRLML6302

D = IRLML5103

E = IRLML6402

F = IRLML6401

G = IRLML2502

H = IRLML5203

YEAR	Y	WORK WEEK	W
2001	1	01	A
2002	2	02	B
2003	3	03	C
1994	4	04	D
1995	5		
1996	6		
1997	7		
1998	8		
1999	9		
2000	0	24	X
		25	Y
		26	Z

W = (27-52) IF PRECEDED BY A LETTER

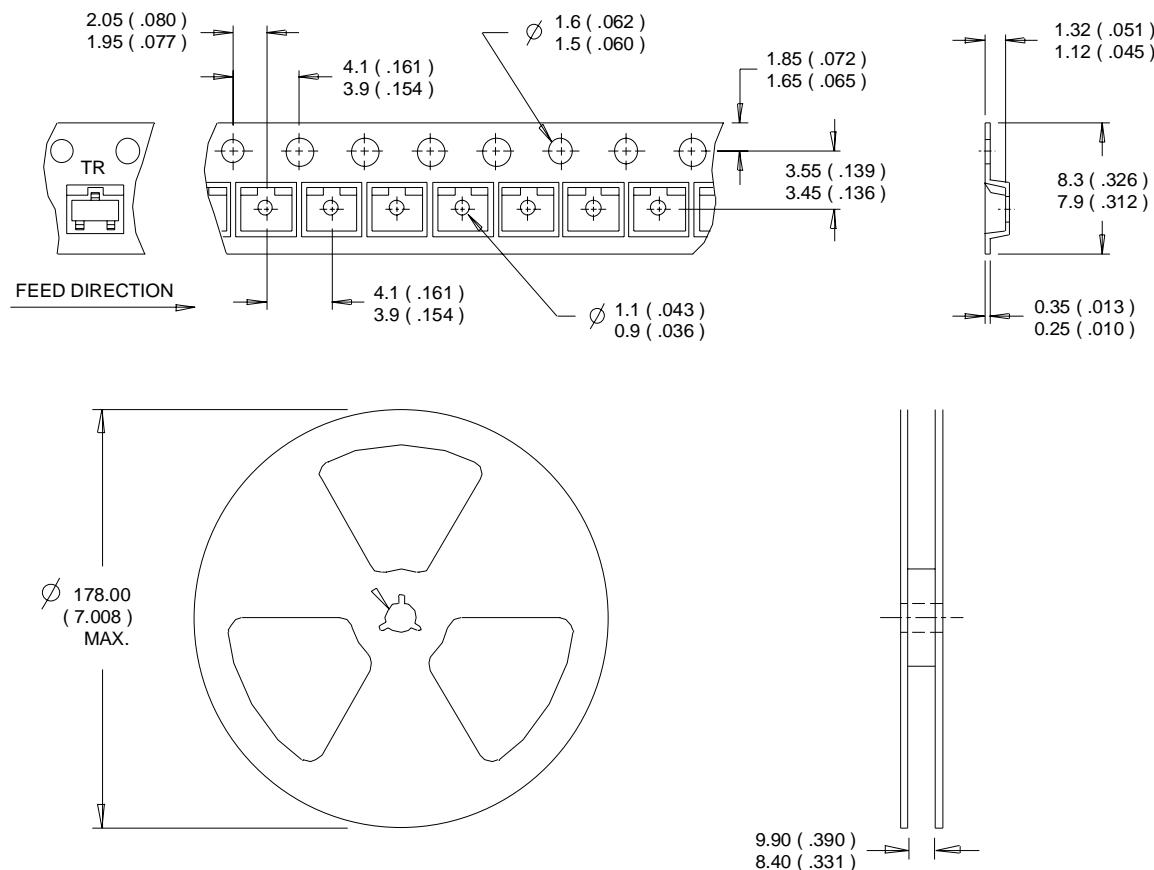
YEAR	Y	WORK WEEK	W
2001	A	27	A
2002	B	28	B
2003	C	29	C
1994	D	30	D
1995	E		
1996	F		
1997	G		
1998	H		
1999	J		
2000	K	50	X
		51	Y
		52	Z

International  
**IR** Rectifier

**IRLML2502**

### Micro3™ Tape & Reel Information

Dimensions are shown in millimeters (inches)



NOTES:

1. CONTROLLING DIMENSION : MILLIMETER.
2. OUTLINE CONFORMS TO EIA-481 & EIA-541.

Data and specifications subject to change without notice.

International  
**IR** Rectifier

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